

R3200x SERIES

Reset Timer IC for Mobile Equipments

NO.EA-280-190531

OUTLINE

The R3200x is a reset timer IC with two input signals for mobile equipment which require long interval for reset sequence. The long interval prevents unexpected resets caused by accidental key operations. Internally, the R3200x consists of a delay generator circuit and output driver transistors.

The R3200x has two active-low input pins (\$\overline{SR0}\$ and \$\overline{SR1}\$) which generate reset signals after output delay time when both active-low input pins are activated at the same time.

The R3200x has two versions that are different in output delay time settings and output release method.

R3200x001x:

Output delay time is selectable from 7.5 s or 11.25 s typ. by connecting the DSR pin to either GND or V_{DD}. A reset signal can be released by making one of the active-low input pins high.

R3200xxx2x, R3200L053B or R3200L064A:

Output delay time is fixed. A reset signal will be released automatically after output release time. Or, by making one of the active-low input pins high, a reset signal can be released before output release time.

The R3200x provides ultra-low supply current while a reset signal is remaining active or after being sent out. The R3200x is offered in a 8-pin DFN(PLP)2020-8B package or a 8-pin DFN1216-8 package.

R3200x

NO.EA-280-190531

FEATURES

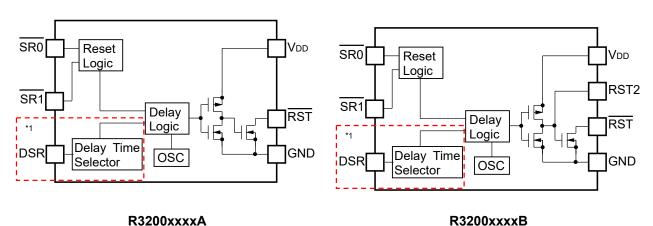
| • | Operating Voltage Range (Maximum Rating) | . 1.65 V to 5.5 V (6 V) |
|---|---|---|
| • | Supply Current 1 (at standby) | . Typ. 0.28 μA (V _{DD} = 5.5 V) |
| • | Supply Current 2 (at active before reset signal output) | . Typ. 3 μA (V _{DD} = 5.5 V) ^{*1} |
| • | Supply Current 3 (at active after reset signal output) | . Typ. 0.45 μA (V _{DD} = 5.5 V) |
| • | Operating Temperature Range | . −40 to +85°C |
| • | Output Delay Time (R3200x001x) | . Typ. 7.5 s or 11.25 s |
| | (R3200x002x) | . Typ. 7.5 s |
| | (R3200L052B) | . Typ. 10 s |
| | (R3200L053B) | Typ. 10 s |
| | (R3200L064A) | Typ. 3.0 s |
| • | Output Delay Time Accuracy | ±10% |
| • | Output Release Time (R3200x002x) | Typ. 0.234 s |
| | (R3200L052B) | Typ. 0.313 s |
| | (R3200L053B) | Typ. 0.078 s |
| | (R3200L064A) | . Typ. 0.1875 s |
| • | Output Release Time Accuracy | . ±10% |
| • | Output Type (R3200xxxxA) | . Nch Open Drain |
| | (R3200xxxxB) | . Nch Open Drain and CMOS |
| • | Packages | . DFN(PLP)2020-8B, DFN1216-8 |

^{*1} Guaranteed by design engineering

APPLICATIONS

- Mobile phone, Smartphone
- Tablet devices such as E-book etc.
- Portable Games
- Personal Navigation Devices

BLOCK DIAGRAMS



SELECTION GUIDE

The package type, the combination of output delay time and output release time, the output type for the device are user-selectable options.

Selection Guide

| Product Name | Package | Quantity per Reel | Pb Free | Halogen Free |
|---------------|-----------------|-------------------|---------|--------------|
| R3200Kxxx*-TR | DFN(PLP)2020-8B | 5,000 pcs | Yes | Yes |
| R3200Lxxx*-E2 | DFN1216-8 | 5,000 pcs | Yes | Yes |

xxx: Specify the combination of output delay time and output release method.

(001) Select the output delay time from 7.5 s or 11.25 s typ.

A reset signal can be released by making one of the active-low input pins high.

(xx2) / (053) / (064)

A reset signal will be released automatically after output release time.

A reset signal can be released before output release time by making one of the active-low input pins high.

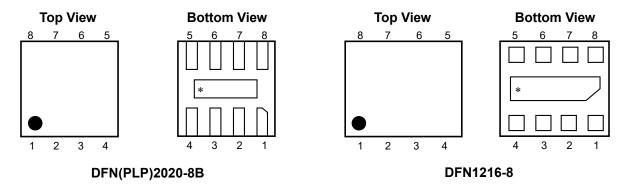
Refer to the table below for the output delay time and the output release time for each device.

| | Output Delay Time | Output Release Time |
|-----------------------|-------------------|---------------------|
| 002 | 7.5 s | 0.234 s |
| 052 (R3200L052B only) | 10 s | 0.313 s |
| 053 (R3200L053B only) | 10 s | 0.078 s |
| 064 (R3200L064A only) | 3.0 s | 0.1875 s |

- *: Specify the output type.
 - (A) Nch Open Drain
 - (B) Nch Open Drain and CMOS

^{*1} The parts surrounded by red dotted lines are for the R3200x001x only.

PIN DESCRIPTIONS



* The tab on the bottom of the package enhances thermal performance and is electrically connected to GND (substrate level). It is recommended that the tab be connected to the ground plane on the board, or otherwise be left floating.

DFN(PLP)2020-8B Pin Description/ DFN1216-8 Pin Description

| Pin No. | Symbol | Description | | |
|---------|--------------------------------|--|--|--|
| 1 | NC | No Connection (R3200xxxxA) | | |
| 1 | RST2 | CMOS Output Pin, Active-high (R3200xxxxB) | | |
| 2 | GND | Ground Pin | | |
| 3 | SR1 | Input Pin2, Active-low*1 | | |
| 4 | RST | Nch Open Drain Output Pin, Active-low*2 | | |
| 5 | DSR | Output Delay Time Selection Pin (R3200x001x) (GND: 7.5 s, V _{DD} : 11.25 s) ^{*3} | | |
| 5 | TEST2 | Test Pin 2*4 (R3200xxx2x/ R3200L053B/ R3200L064A) | | |
| 6 | 6 TEST Test Pin*4 | | | |
| 7 | 7 SR0 Input Pin1, Active-low*1 | | | |
| 8 | V_{DD} | Power Supply Input Pin | | |

^{*1} When only one active-low input pin is used, connect the unused one to GND.

^{*2} The RST pin must be connected to GND or left floating if it is not used (Ex.R3200xxxxB).

 $^{^{\}star3}$ The DSR pin must be connected to GND or V_{DD} .

^{*4} The TEST pin and the TEST2 pin must be connected to GND when they are used.

ABSOLUTE MAXIMUM RATINGS

Absolute Maximum Ratings

| Symbol | Item | Item Rating | | Unit |
|-------------------|--|----------------------------------|---------|------|
| V_{DD} | Supply Voltage | GND -0 | .3 to 6 | V |
| V _{SR0} | Input Voltage (Input Pin1) | GND -0 | .3 to 6 | V |
| V _{SR1} | Input Voltage (Input Pin2) | GND -0 | .3 to 6 | V |
| V _{RST} | Output Voltage (Reset Signal Output Pin1) | GND -0 | .3 to 6 | V |
| V _{RST2} | Output Voltage (Reset Signal Output Pin2) | GND -0.3 to V _{DD} +0.3 | | V |
| V_{DSR} | Input Voltage (Output Delay Time Selection Pin) (R3200x001x) | GND -0.3 to 6 | | V |
| I _{OUT} | Output Current | 20 | | mA |
| D- | Power Dissipation (JEDEC STD. 51)*1 | DFN(PLP)2020-8B | 1050 | m\\/ |
| P _D | Power Dissipation (JEDEC STD. 51) | DFN1216-8 | 1700 | mW |
| Та | Operating Temperature Range | -40 to +85 | | °C |
| Tstg | Storage Temperature Range | −55 to +125 | | °C |

^{*1} Refer to PACKAGE INFORMATION for detailed information.

ABSOLUTE MAXIMUM RATINGS

Electronic and mechanical stress momentarily exceeded absolute maximum ratings may cause permanent damage and may degrade the life time and safety for both device and system using the device in the field. The functional operation at or over these absolute maximum ratings is not assured.

RECOMMENDED OPERATING CONDITIONS (ELECTRICAL CHARACTERISTICS)

All of electronic equipment should be designed that the mounted semiconductor devices operate within the recommended operating conditions. The semiconductor devices cannot operate normally over the recommended operating conditions, even if they are used over such conditions by momentary electronic noise or surge. And the semiconductor devices may receive serious damage when they continue to operate over the recommended operating conditions.

| _ | _ | _ | _ | _ | |
|---|---|----|---|---|---|
| _ | ~ | 2 | ^ | ^ | |
| _ | - | _, | | | v |
| | | | | | |

ELECTRICAL CHARACTERISTICS

The specifications surrounded by are guaranteed by design engineering at $-40^{\circ}\text{C} \le \text{Ta} \le 85^{\circ}\text{C}$.

R3200x001x Electrical Characteristics

 $(Ta = 25^{\circ}C)$

| Symbol | Item | Cond | itions | Min. | Тур. | Max. | Unit |
|------------------|-----------------------------------|--|--------------------------|---------------------------|-------|--------|------|
| V _{DD} | Supply Voltage | | | 1.65 | | 5.5 | V |
| Iss ₁ | Supply Current 1*1 | V _{DD} = 5.5 V (at s | tandby) | | 0.28 | 1.35 | μΑ |
| I _{SS2} | Supply Current 2*2 | V _{DD} = 5.5 V (at active before r | eset signal output) | | 3.0 | 6.5 | μΑ |
| Iss3 | Supply Current 3*3 | V _{DD} = 5.5 V (at active after re | set signal output) | | 0.45 | 1.7 | μΑ |
| | | V _{DD} ≥ 4.5 V | I _{OL} = 8 mA | | | | |
| Vol | "L" Output Voltage | V _{DD} ≥ 3.3 V | I _{OL} = 5 mA | | | 0.3 | V |
| | | V _{DD} ≥ 1.65 V | I _{OL} = 3 mA | | | | |
| | | V _{DD} ≥ 4.5 V | I _{OH} = 5 mA | | | | |
| Vон | "H" Output Voltage*4 | V _{DD} ≥ 3.3 V | I _{OH} = 2.5 mA | V _{DD} x 0.85 | | | V |
| | | V _{DD} ≥ 1.65 V | I _{OH} = 0.8 mA | X 0.00 | | | |
| ILEAKI | SR0, SR1 Input Leakage Current | V _{DD} = 5.5 V | | | | 0.1 | μΑ |
| ILEAKO | Output Leakage Current | $V_{DD} = 5.5 \text{ V}$ | | | | 0.1 | μΑ |
| tdelay | Output Delay Time | DSR = GND | | 6.75 | 7.5 | 8.25 | S |
| luelay | Output Delay Tillle | DSR = V _{DD} | | 10.125 | 11.25 | 12.375 | S |
| VIL | SR0, SR1 "L" Input Voltaget | | | | | 0.3 | V |
| V _{IH} | SR0, SR1 "H" Input Voltaget | | | 0.85 | | | V |

All test items listed under *ELECTRICAL CHARACTERISTICS* are done under the pulse load condition (Tj \approx Ta = 25°C) except Supply Current 2.

^{*1} Supply current when the device is active and waiting for the reset input.

^{*2} Supply current when both active-low input pins are low and the timer operation is running.

^{*3} Supply current after the completion of timer operation and the output of reset signal.

^{*4} For the R3200xxxxB only (CMOS output).

ELECTRICAL CHARACTERISTICS (continued)

The specifications surrounded by are guaranteed by design engineering at $-40^{\circ}\text{C} \le \text{Ta} \le 85^{\circ}\text{C}$.

R3200xxx2x, R3200L053B, R3200L064A Electrical Characteristics

 $(Ta = 25^{\circ}C)$

| Symbol | Item | Cond | litions | Min. | Тур. | Max. | Unit |
|------------------|-----------------------------------|--|--------------------------|---------------------------|----------|-------------------|----------|
| V_{DD} | Operating Voltage | | | 1.65 | | 5.5 | V |
| Iss ₁ | Supply Current 1*1 | V _{DD} = 5.5 V (at s | standby) | | 0.28 | 1.35 | μA |
| Iss2 | Supply Current 2*2 | V _{DD} = 5.5 V (at active before reset signal output) | | | 3.0 | 6.5 | μA |
| Iss ₃ | Supply Current 3*3 | $V_{DD} = 5.5 V$ (at active after re | eset signal output) | | 0.45 | 1.7 | μA |
| | | V _{DD} ≥ 4.5 V | I _{OL} = 8 mA | | | | |
| Vol | "L" Output Voltage | V _{DD} ≥ 3.3 V | I _{OL} = 5 mA | | | 0.3 | V |
| | | V _{DD} ≥ 1.65 V | I _{OL} = 3 mA | | | | |
| | "H" Output Voltage*4 | V _{DD} ≥ 4.5 V | I _{OH} = 5 mA | V _{DD} x 0.85 | | | |
| Vон | | V _{DD} ≥ 3.3 V | I _{OH} = 2.5 mA | | | | V |
| | | V _{DD} ≥ 1.65 V | I _{OH} = 0.8 mA | х 0.00 | | | |
| ILEAKI | SR0, SR1 Input Leakage Current | V _{DD} = 5.5 V | | | | 0.1 | μΑ |
| ILEAKO | Output Leakage Current | $V_{DD} = 5.5 \text{ V}$ | | | | 0.1 | μΑ |
| tdelay | Output Delay Time*5 | | | tdelay_s x 0.9 | tdelay_s | tdelay_s x 1.1 | sec |
| trec | Output Release Time*5 | | | trec_s x 0.9 | trec_s | trec_s x 1.1 | sec |
| VIL | SR0, SR1 "L" Input Voltage | | | | | 0.3 | V |
| VIH | SR0, SR1 "H" Input Voltage | | | 0.85 | | | ٧ |

All test items listed under *ELECTRICAL CHARACTERISTICS* are done under the pulse load condition (Tj \approx Ta = 25°C) except Supply Current 2.

Output Delay Time and Output Release Time of R3200x

| Product Name | tdelay_s | trec_s |
|--------------|----------|----------|
| R3200x002x | 7.5 s | 0.234 s |
| R3200L052B | 10 s | 0.313 s |
| R3200L053B | 10 s | 0.078 s |
| R3200L064A | 3.0 s | 0.1875 s |

^{*1} Supply current when the device is active and waiting for the reset input.

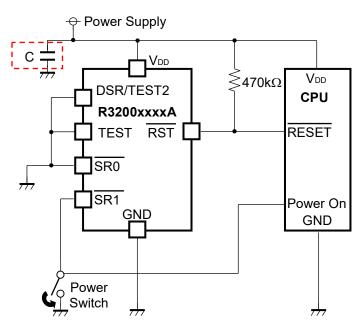
^{*2} Supply current when both active-low input pins are low and the timer operation is running.

^{*3} Supply current after the automatic cancellation of reset signal following the completion of timer operation and the output of rest signal.

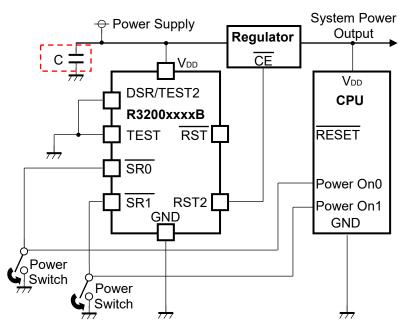
^{*4} For the R3200xxxxB only (CMOS output).

^{*5} Refer to Output Delay Time and Output Release Time of R3200x.

TYPICAL APPLICATIONS



R3200xxxxA Typical Application



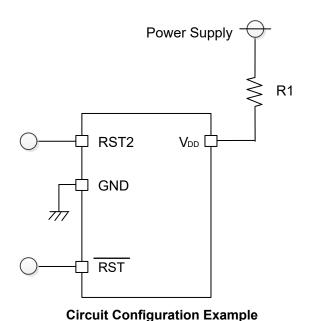
R3200xxxxB Typical Application

A bypass capacitor between the power supply line and the GND line is not necessarily required. If the device operation is affected by power supply noise, connect an appropriately selected bypass capacitor.

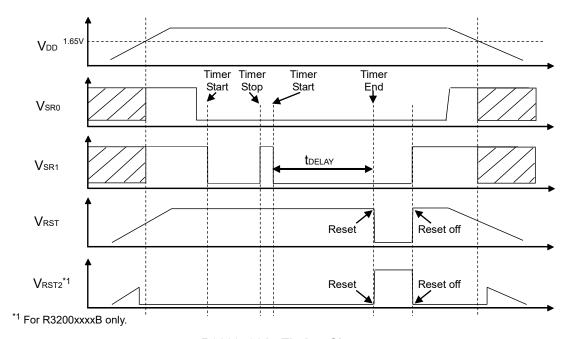
TECHNICAL NOTES

The performance of power source circuits using this device largely depends on the peripheral circuits. When selecting the peripheral components, consider the conditions of use. Do not allow each component, PCB pattern and the device to exceed their respected rated values (voltage, current and power) when designing the peripheral circuits.

- When only one active-low input pins is used (refer to R3200xxxxA Typical Application) connect the unused one to GND.
- In the case of applying the following circuit configuration to the R3200x, the supply current of the device itself may cause significant voltage drop on the V_{DD} pin if the R1 value is high. As a result, the V_{DD} voltage may fall below the minimum operating voltage.

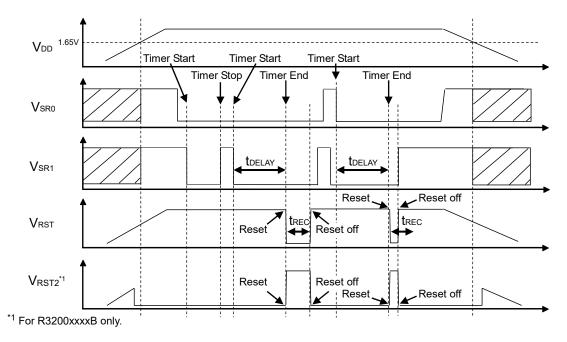


THEORY OF OPERATION



R3200x001x Timing Chart

- When both active-low input pins become the low voltage level, the timer operation starts. After the output delay time (tdelay), a reset signal will be sent out. When one of the active-low input pins becomes the high voltage level, the timer operation stops.
- During tdealy, if one of the active-low input pins becomes the high voltage level, the timer operation stops.
 If both active-low input pins become the low voltage level again, a reset signal will be sent out after tdelay.
- A reset signal will be released if one of the active-low input pins becomes the high voltage level. Until one of the active-low input pins becomes the high voltage level, a reset signal will be continually sent out.
- tdelay can be selected from 7.5 s or 11.25 s typ. by connecting the DSR pin to either GND or V_{DD}.
 However, if the DSR pin is switched during the operations, the output would become unstable and may cause false operations. Switching of the DSR pin must be done during power-off.
 - Also, the DSR pin must be connected to either GND or V_{DD} , otherwise the output would become unstable and may cause false operations.



R3200xxx2x, R3200L053B, R3200L064A Timing Chart

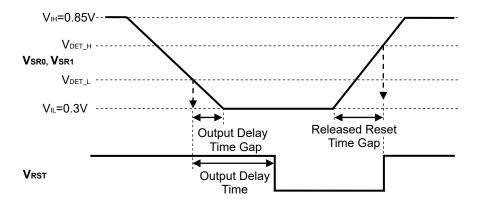
- When both active-low input pins become the low voltage level, the timer operation starts. After the output delay time (tdelay), a reset signal will be sent out. If one of the active-low input pins becomes the high voltage level, the timer operation stops.
- During tdelay, if one of the active-low input pins becomes the high voltage level, the timer operation stops. If both active-low input pins become the low voltage level again, a reset signal will be sent out after tdelay.
- A reset signal will be released automatically after the reset delay time (trec), or it will be released if one of the active-low input pins becomes the high voltage level.

R3200x

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OUTPUT DELAY TIME GAP

The threshold voltages of the active-low input pins are between V_{IL} and V_{IH} . Therefore, if the rising or falling slew rate is very slow, the timer will start at the point of crossing the threshold voltage and may cause errors in the output delay time (tdelay) and the output release time (trec).



Relation between the Rising and Falling Slew Rate and the Time Gap

VDD START-UP DURING LOW INPUT

When starting up V_{DD} at slow slew rate of 0.001 V/ μ s or less while the active-low input pins are the low voltage level, the device may start the operation at lower than the minimum operating voltage, thus tdelay may exceed the guaranteed time.

PACKAGE INFORMATION

Power Dissipation (DFN(PLP)2020-8B)

The power dissipation of the package is dependent on PCB material, layout, and environmental conditions. The following measurement conditions are based on JEDEC STD. 51-7.

Measurement Conditions

| Item | Measurement Conditions |
|---|--|
| Environment Mounting on Board (Wind Velocity = 0 m/s) | |
| Board Material Glass Cloth Epoxy Plastic (Four-Layer Board) | |
| Board Dimensions | 76.2 mm × 114.3 mm × 0.8 mm |
| Copper Ratio | Outer Layer (First Layer): Less than 95% of 50 mm Square Inner Layers (Second and Third Layers): Approx. 100% of 50 mm Square Outer Layer (Fourth Layer): Approx. 100% of 50 mm Square |
| Through-holes | φ 0.3 mm × 23 pcs |

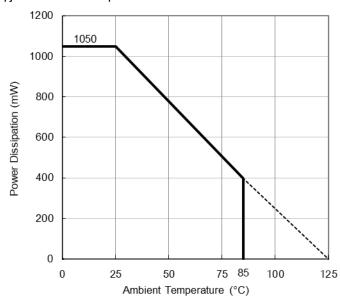
Measurement Result

 $(Ta = 25^{\circ}C, Tjmax = 125^{\circ}C)$

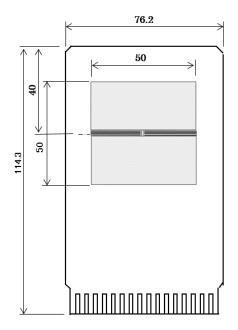
| Item | Measurement Result |
|--|--------------------|
| Power Dissipation | 1050 mW |
| Thermal Resistance (θja) | θja = 92°C/W |
| Thermal Characterization Parameter (ψjt) | ψjt = 60°C/W |

 θ ja: Junction-to-Ambient Thermal Resistance

ψjt: Junction-to-Top Thermal Characterization Parameter

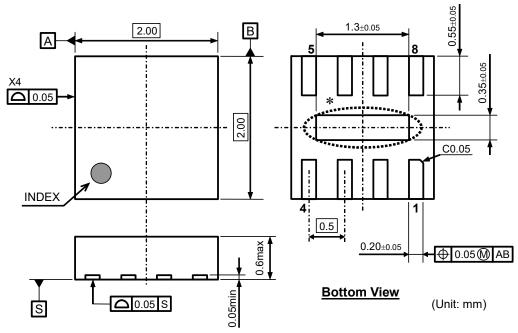


Power Dissipation vs. Ambient Temperature



Measurement Board Pattern

PACKAGE DIMENSIONS (DFN(PLP)2020-8B)



* The tab on the bottom of the package enhances thermal performance and is electrically connected to GND (substrate level).

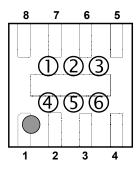
It is recommended that the tab be connected to the ground plane on the board, or otherwise be left floating.

DFN(PLP)2020-8B Package Dimensions

MARK SPECIFICATION (DFN(PLP)2020-8B)

①②③④: Product Code ... Refer to MARK SPECIFICATION TABLE (DFN(PLP)2020-8B).

⑤⑥: Lot Number ... Alphanumeric Serial Number



DFN(PLP)2020-8B Mark Specification

MARK SPECIFICATION TABLE (DFN(PLP)2020-8B)

R3200K Mark Specification Table

| Product Name | 0234 |
|--------------|---------|
| R3200K001A | D 0 0 1 |
| R3200K001B | D D 0 2 |
| R3200K002A | D D 0 3 |
| R3200K002B | D D 0 4 |

R3200x

NO.EA-280-190531

Power Dissipation (DFN1216-8)

The power dissipation of the package is dependent on PCB material, layout, and environmental conditions. The following conditions are based on JEDEC STD. 51-7.

Measurement Conditions

| Item | Measurement Conditions | |
|------------------|--|--|
| Environment | Mounting on Board (Wind Velocity = 0 m/s) | |
| Board Material | Glass Cloth Epoxy Plastic (Four-Layer Board) | |
| Board Dimensions | 76.2 mm × 114.3 mm × 0.8 mm | |
| Copper Ratio | Outer Layer (First Layer): Less than 95% of 50 mm Square Inner Layers (Second and Third Layers): Approx. 100% of 50 mm Square Outer Layer (Fourth Layer): Approx. 100% of 50 mm Square | |
| Through-holes | φ 0.2 mm × 15 pcs | |

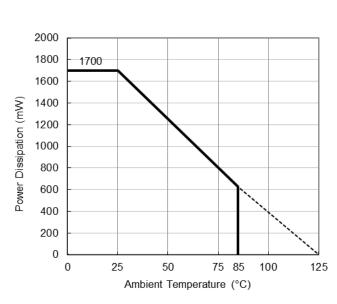
Measurement Result

 $(Ta = 25^{\circ}C, Tjmax = 125^{\circ}C)$

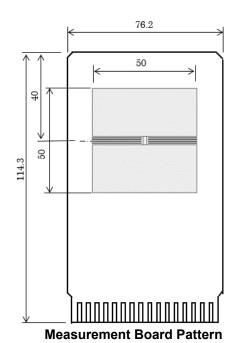
| Item | Measurement Result |
|--|--------------------|
| Power Dissipation | 1700 mW |
| Thermal Resistance (θja) | θja = 56°C/W |
| Thermal Characterization Parameter (ψjt) | ψjt = 18°C/W |

 θ ja: Junction-to-Ambient Thermal Resistance

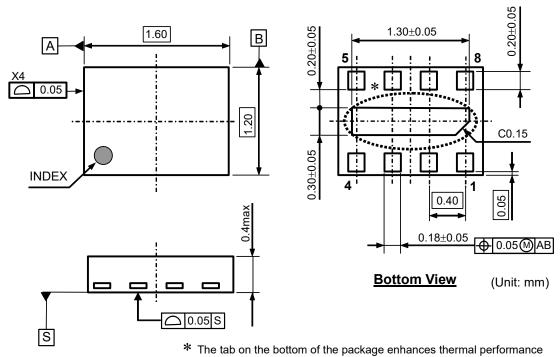
ψjt: Junction-to-Top Thermal Characterization Parameter



Power Dissipation vs. Ambient Temperature



PACKAGE DIMENSIONS (DFN1216-8)



and is electrically connected to GND (substrate level).

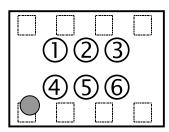
It is recommended that the tab be connected to the ground plane on the board, or otherwise be left floating.

DFN1216-8 Package Dimensions

MARK SPECIFICATION (DFN1216-8)

①②③④: Product Code ... Refer to MARK SPECIFICATION TABLE (DFN1216-8).

⑤⑥: Lot Number ... Alphanumeric Serial Number



DFN1216-8 Mark Specification

R3200x

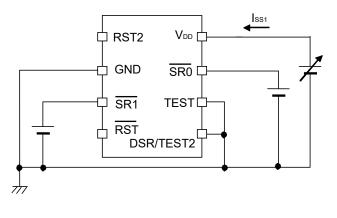
NO.EA-280-190531

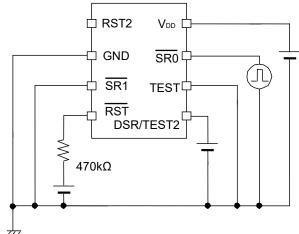
MARK SPECIFICATION TABLE (DFN1216-8)

R3200L Mark Specification Table

| Product Name | 0234 | | |
|--------------|---------|--|--|
| R3200L001A | D E 0 1 | | |
| R3200L001B | D F 0 2 | | |
| R3200L002A | D E 0 3 | | |
| R3200L002B | D E 0 4 | | |
| R3200L052B | D E 0 5 | | |
| R3200L053B | D E 0 6 | | |
| R3200L064A | D E 0 7 | | |

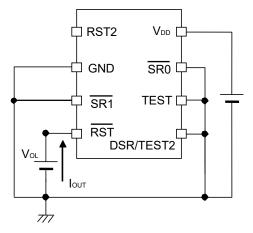
TEST CIRCUITS



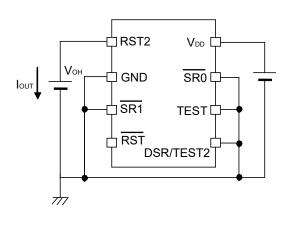


Supply Current Test Circuit

Output Delay Time Test Circuit



Nch Driver Output Voltage Test Circuit

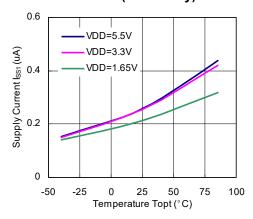


CMOS Driver Output Voltage Test Circuit (For the R3200xxxxB only.)

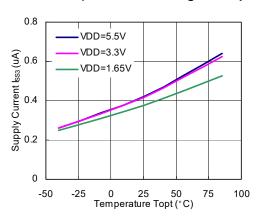
TYPICAL CHARACTERISTICS

Note: Typical Characteristics are intended to be used as reference data; they are not guaranteed.

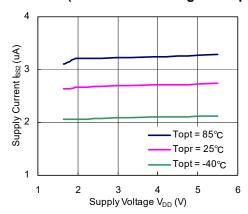
1) Supply Current 1 vs. Temperature R3200x (at standby)



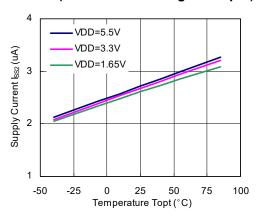
3) Supply Current 3 vs. Temperature R3200x (after the reset signal output)



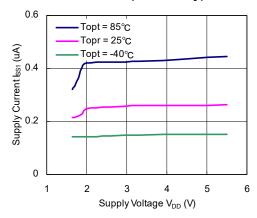
5) Supply Current 2 vs. Supply Voltage R3200x (before the reset signal output)



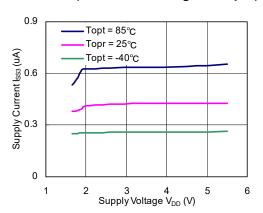
2) Supply Current 2 vs. Temperature R3200x (before the reset signal output)



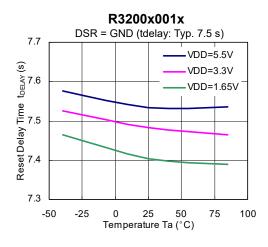
4) Supply Current 1 vs. Supply Voltage R3200x (at standby)

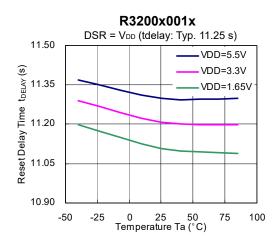


6) Supply Current 2 vs. Supply Voltage R3200x (after the reset signal output)

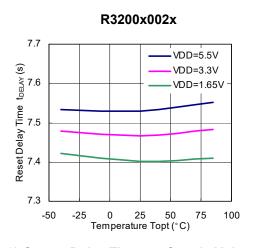


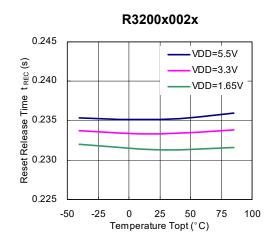
7) Output Delay Time vs. Temperature



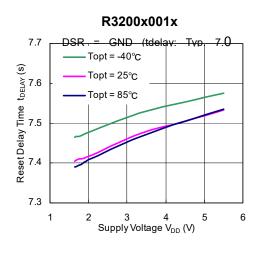


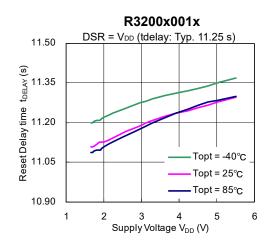
8) Output Release Time vs. Temperature

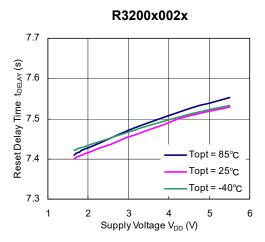




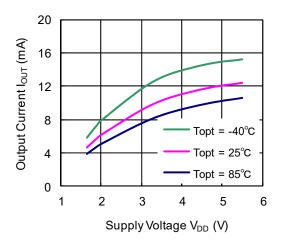
9) Output Delay Time vs. Supply Voltage



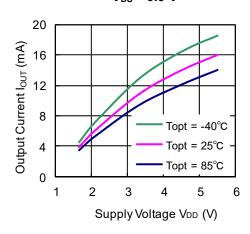




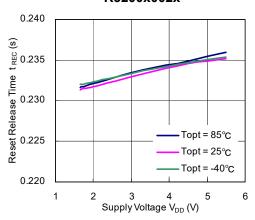
11) Nch Driver Output Current vs. Supply Voltage $V_{DS} = 0.3 \text{ V}$



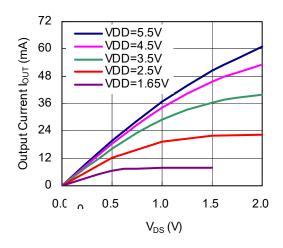
13) Pch Driver Output Current vs. Supply Voltage $V_{DS} = 0.9 \text{ V}$



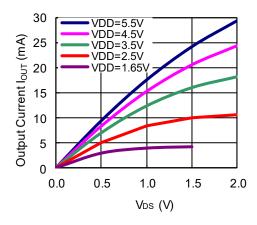
10) Output Release Time vs. Supply Voltage R3200x002x



12) Nch Driver Output Current vs. V_{DS}



14) Pch Driver Output Current vs. VDS





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